

Title: Comparison of Integrated vs. Discrete Op-Amps:

Lab Section: Friday Lab, Brauer

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Scientific Question:

Do discrete transistor op-amps perform comparably to integrated circuit op-amps across a wide frequency spectrum?

Hypothesized Answer:

No, we do not believe that the transistor op-amp will perform comparably to the integrated circuit op-amp due to parasitic resistances and capacitances in the breadboard.

Purpose:

The scientific aim of this lab is to explore the differences between op-amp architectures and analyze the potential benefits and drawbacks of each op-amp choice. This experiment is important as it builds a deeper understanding of the underlying principals and intuition behind op-amps and the variations in op-amps.

Equipment:

- Four NPN transistors—models 2N2222 or 2N3403
- Two PNP transistors—models 2N2907 or 2N3906
- Two 10 k Ω potentiometers, single-turn, linear taper
- One 270 k Ω resistor
- Three 100 k Ω resistors
- One 10 k Ω resistor
- Function generator – BK Precision 4017A
- Oscilloscope – Tektronix TDS 210 or 1002B
- Oscilloscope probe, 10 \times or 10 \times /1 \times
- BNC-to-BNC patch cables, short (2)
- BNC-to-mini-grabber connector (3)
- Banana-to-mini-grabber, black
- Banana-to-mini-grabber, red
- Banana-to-banana, black
- Banana-to-banana, red
- Resistor decade box
- Powered circuit board with amplifiers
- BNC-to-DIN8 adapter

Overview:

1. Build the discrete transistor op-amp circuit by following the schematic:

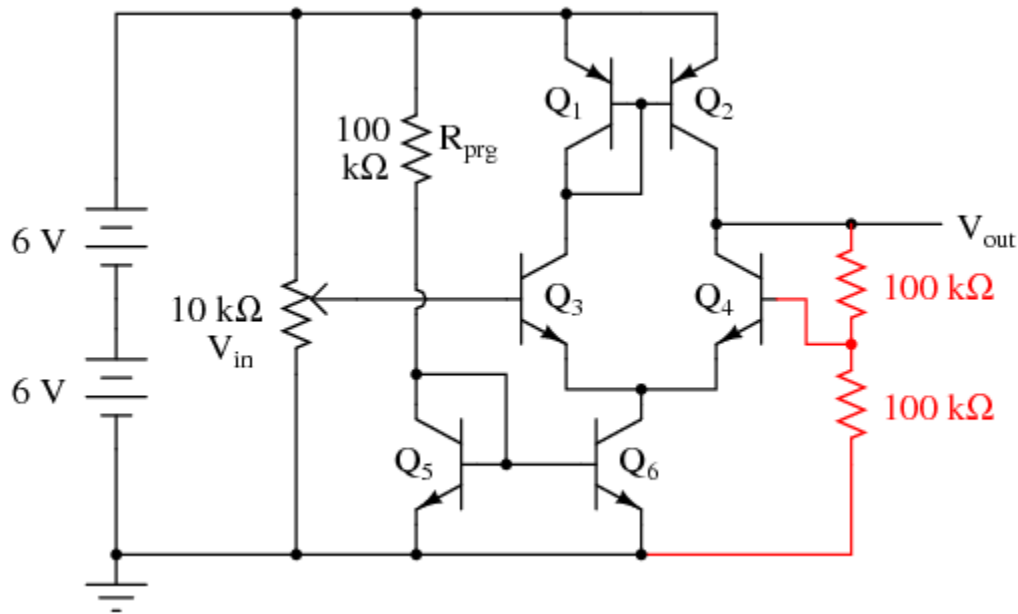


Figure 1: Discrete Op-amp Schematic

2. Setup the LM741 on the breadboard, same as PLab 1a setup
3. Measure and test differential gain, common-mode gain, and input impedance for both op-amps
4. Present comparison of the various parameters and aspects of each op-amp architecture

Procedure 1: Amplifier Gain Comparison

The scientific aim of this procedure is to explore the differences in differential gain between op-amp architectures and analyze the potential benefits and drawbacks of each op-amp choice.

Resources:

Construct an op-amp that follows the schematic from figure 1 on the breadboard. Construct an op-amp circuit with the same 2x 100-ohm feedback resistors. Follow PLab Procedure 1A if unsure.

Methods:

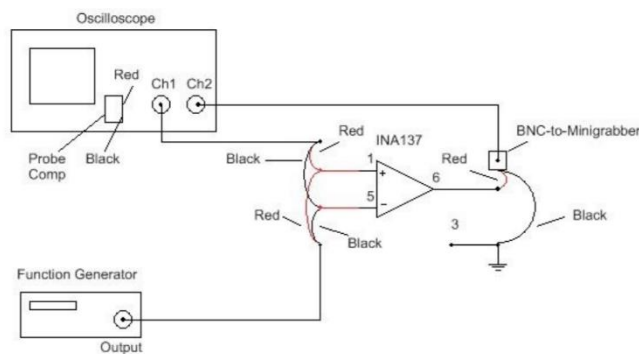


Figure 2: Wiring diagram for op-amp testing configuration.

The oscilloscope will display the input voltage, V_{in} , on Channel 1 and the output voltage, V_{out} , on Channel 2. It is a good idea to monitor both the input and output voltages.

Data Collection

Apply a sinusoidal signal of approximately 1 V_{p-p} to V_{in} . Record the exact value of V_{in} and V_{out} , and calculate the differential gain G_d of each amplifier.

Procedure 2: Common Mode Rejection Ratio

The scientific aim of this procedure is to explore the differences in common gain between op-amp architectures and calculate the common-mode rejection ratio, which is a measure of how well the device can measure small signal differentials in the face of noise.

Methods

The common-mode gain (G_d) for both op-amps has already been measured in the previous procedure. Now measure G_c by connecting the two input pins to the same input signal with respect to ground. The function generator signal is still V_{in} , but you should connect the positive lead of the function generator output to both input pins, and the negative lead of the function generator output should be connected to ground. Read V_{out} with respect to ground. Read V_{in} on Ch1 and V_{out} on Ch2 of the oscilloscope.

Data Collection

Use the same 1 V_{p-p} signal as before for your input. Use frequencies of 10 Hz, 100 Hz, 1 kHz, and 10 kHz for both op-amps. Record V_{in} and V_{out} at each frequency, and calculate the common-mode gain G_c of

each amplifier when the function generator signal is applied to both amplifier inputs. It may be difficult to measure V_{out} as it is small.

Procedure 3: Measurement of Input Impedance

Resources

Using an external resistance in series with the function generator signal, one can measure the input impedance of the op-amp under test, via the method covered in PLab 1. The Input impedance can be measured via the formula: $V_{out} = G V_{in} = G (R_i / (R_i + R_e)) V_s$

Methods

The function generator will be used to measure the input impedance of the two amplifier chips. Connect the output of the function generator in the place of V_s , and the resistor decade box in the place of R_e , as shown in the following figure

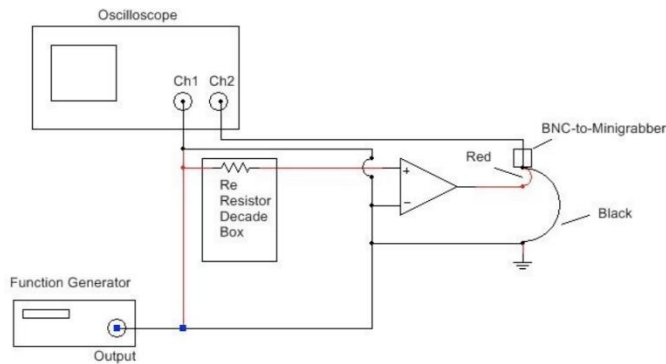


Figure 3: This figure shows the wiring setup for measuring the input impedance of the op-amp

Data Collection

Increase the resistance on the decade box until a significant drop in V_{out} is seen. There will likely be large amounts of noise and drift in the output signal. Record your final values for R_e , V_s , and V_{out} for each of the two amplifiers.